

# N- Channel Enhancement mode MOSFET AND PNP BJT Complex Device

## MBNP2026G6

### Description

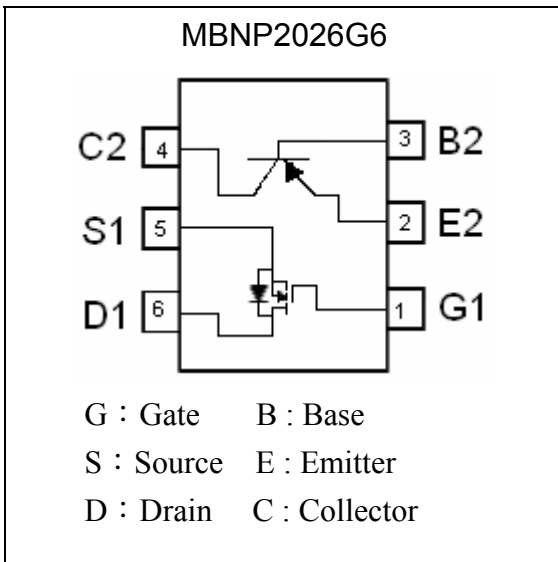
The MBNP2026G6 consists of a N-channel enhancement-mode MOSFET and a PNP BJT in a single TSOP-6 package, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TSOP-6 package is universally preferred for all commercial-industrial surface mount applications.

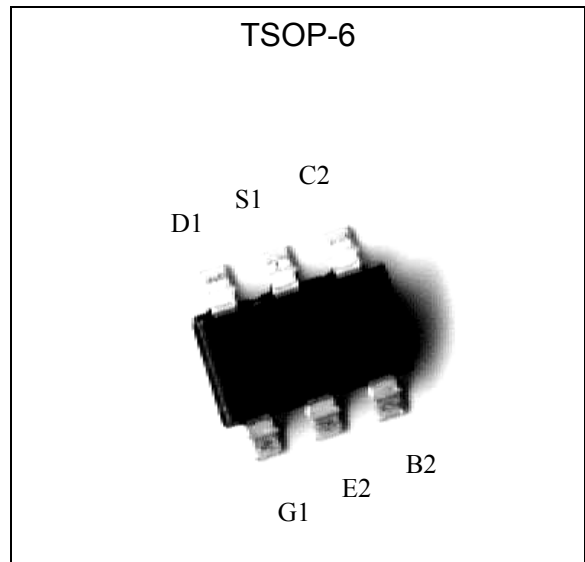
### Features

- Simple drive requirement
- Low gate charge
- Low on-resistance
- Fast switching speed
- Pb-free package

### Equivalent Circuit



### Outline





**Absolute Maximum Ratings** (Ta=25°C)

Parameter	Symbol	Limits		Unit
		N-channel	PNP	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30		V
Gate-Source Voltage	V <sub>GS</sub>	±12		V
Collector-Base Voltage	V <sub>CB0</sub>		-40	V
Collector-Emitter Voltage	V <sub>CEO</sub>		-30	V
Emitter-Base Voltage	V <sub>EBO</sub>		-5	V
Continuous Drain Current (Note 1)	I <sub>D</sub>	100		mA
Pulsed Drain Current (Note 2)	I <sub>DM</sub>	400		mA
Collector Current(DC) (Note 1)	I <sub>C</sub>		-3	A
Peak Collector Current (Note 2)	I <sub>CM</sub>		-5	A
Peak Base Current (Note 2)	I <sub>BM</sub>		-500	mA
Total Power Dissipation (Note 1) Linear Derating Factor	Pd	1.3		W
		0.01		W / °C
Operating Junction and Storage Temperature	T <sub>j</sub> , T <sub>stg</sub>	-55~+150		°C
Thermal Resistance, Junction-to-Ambient (Note 1)	R <sub>th,ja</sub>	110		°C/W

Note : 1.Surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board, t≤5 sec; 180°C/W when mounted on minimum copper pad  
 2.Pulse width limited by maximum junction temperature

**N-Channel MOSFET Electrical Characteristics** (Tj=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	30	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> =100μA
V <sub>GS(th)</sub>	0.8	1.3	1.5	V	V <sub>DS</sub> =3V, I <sub>D</sub> =100μA
I <sub>GSS</sub>	-	-	±1	μA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0
I <sub>DSS</sub>	-	-	100	nA	V <sub>DS</sub> =30V, V <sub>GS</sub> =0
R <sub>DS(ON)</sub>	-	3.4	8	Ω	V <sub>GS</sub> =4V, I <sub>D</sub> =10mA
	-	6.9	13		V <sub>GS</sub> =2.5V, I <sub>D</sub> =1mA
G <sub>FS</sub>	20	50	-	mS	V <sub>DS</sub> =3V, I <sub>D</sub> =10mA
<b>Dynamic</b>					
C <sub>iSS</sub>	-	12.5	-	pF	V <sub>DS</sub> =5V, V <sub>GS</sub> =0, f=1MHz
C <sub>oSS</sub>	-	7.3	-		
C <sub>rSS</sub>	-	3.5	-		
*t <sub>d(ON)</sub>	-	15	-	ns	V <sub>DD</sub> ≐ 5V, I <sub>D</sub> =10mA, V <sub>GS</sub> =5V, R <sub>L</sub> =500Ω, R <sub>G</sub> =10Ω
*t <sub>r</sub>	-	35	-		
*t <sub>d(OFF)</sub>	-	75	-		
*t <sub>f</sub>	-	75	-		
R <sub>g</sub>	-	1.1	1.7	Ω	f=1MHz
<b>Source-Drain Diode</b>					
*V <sub>SD</sub>	-	0.88	1.2	V	V <sub>GS</sub> =0V, I <sub>S</sub> =100mA

\*Pulse Test : Pulse Width ≤300μs, Duty Cycle ≤2%



**PNP BJT Electrical Characteristics** (Tj=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
BV <sub>CBO</sub>	-40	-	-	V	I <sub>C</sub> =-50μA, I <sub>E</sub> =0
BV <sub>CEO</sub>	-30	-	-	V	I <sub>C</sub> =-1mA, I <sub>B</sub> =0
BV <sub>EBO</sub>	-5	-	-	V	I <sub>E</sub> =-50μA, I <sub>C</sub> =0
I <sub>CBO</sub>	-	-	-100	nA	V <sub>CB</sub> =-40V, I <sub>E</sub> =0
I <sub>EBO</sub>	-	-	-100	nA	V <sub>EB</sub> =-5V, I <sub>C</sub> =0
*V <sub>CE(sat)</sub> 1	-	-	-0.2	V	I <sub>C</sub> =-100mA, I <sub>B</sub> =-1mA
*V <sub>CE(sat)</sub> 2	-	-	-0.3	V	I <sub>C</sub> =-500mA, I <sub>B</sub> =-50mA
*V <sub>CE(sat)</sub> 3	-	-	-0.4	V	I <sub>C</sub> =-1A, I <sub>B</sub> =-100mA
*V <sub>BE(sat)</sub>	-	-	-1.2	V	I <sub>C</sub> =-1A, I <sub>B</sub> =-50mA
*V <sub>BE(on)</sub>	-	-	-1	V	V <sub>CE</sub> =-5V, I <sub>C</sub> =-1A
*h <sub>FE</sub> 1	250	-	500	-	V <sub>CE</sub> =-5V, I <sub>C</sub> =-100mA
*h <sub>FE</sub> 2	180	-	-	-	V <sub>CE</sub> =-5V, I <sub>C</sub> =-500mA
*h <sub>FE</sub> 3	140	-	-	-	V <sub>CE</sub> =-5V, I <sub>C</sub> =-1A
f <sub>T</sub>	-	180	-	MHz	V <sub>CE</sub> =-5V, I <sub>E</sub> =-0.1A, f=100MHz
C <sub>ob</sub>	-	20	-	pF	V <sub>CB</sub> =-10V, f=1MHz

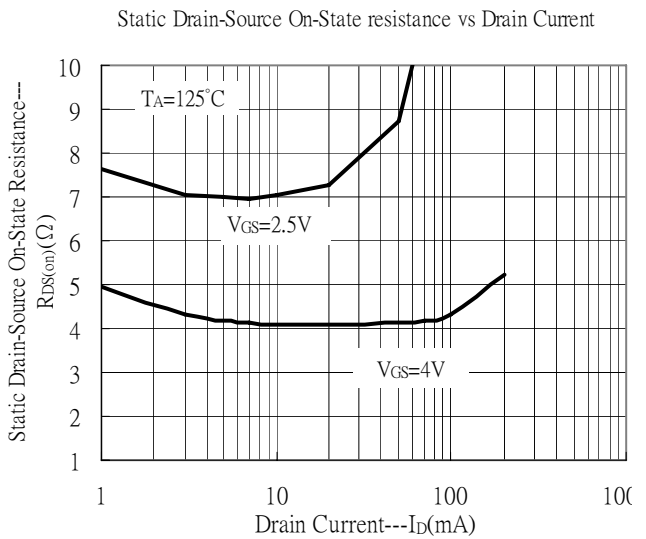
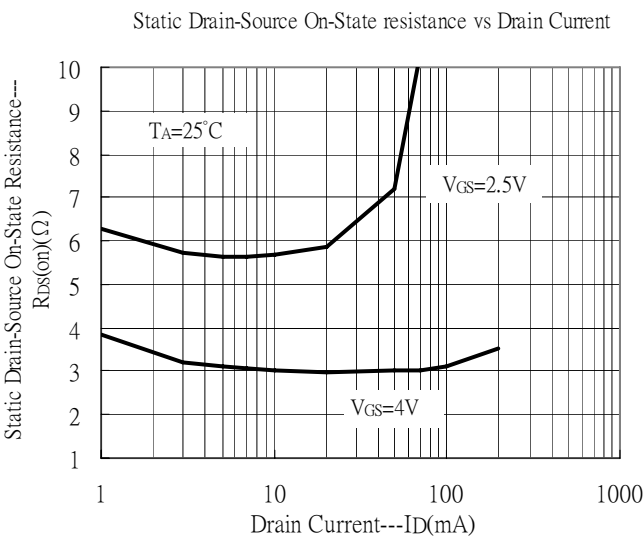
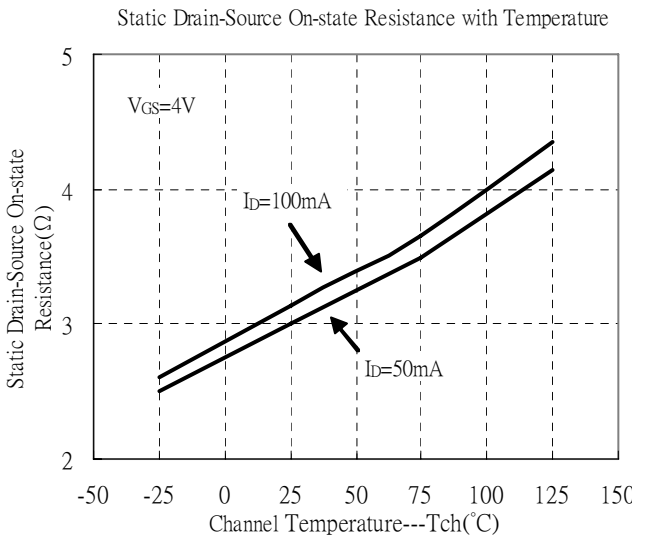
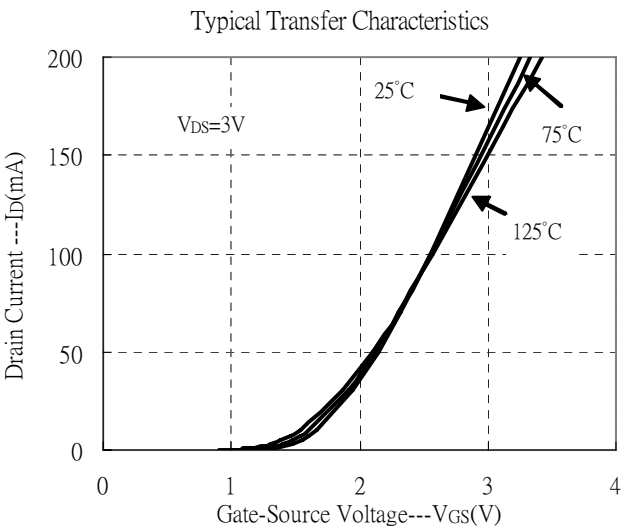
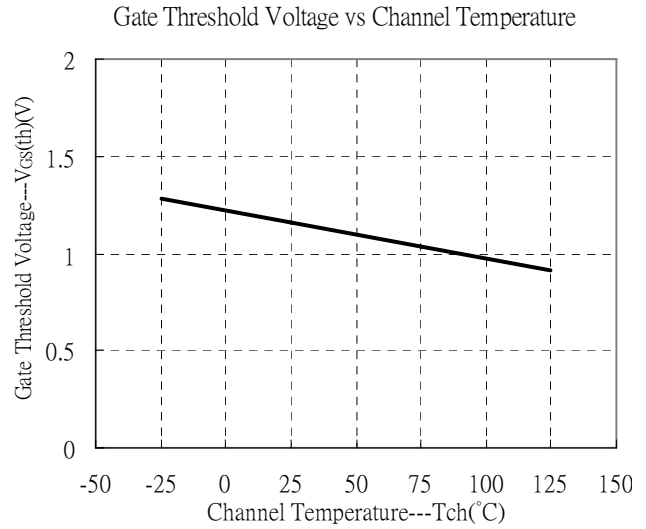
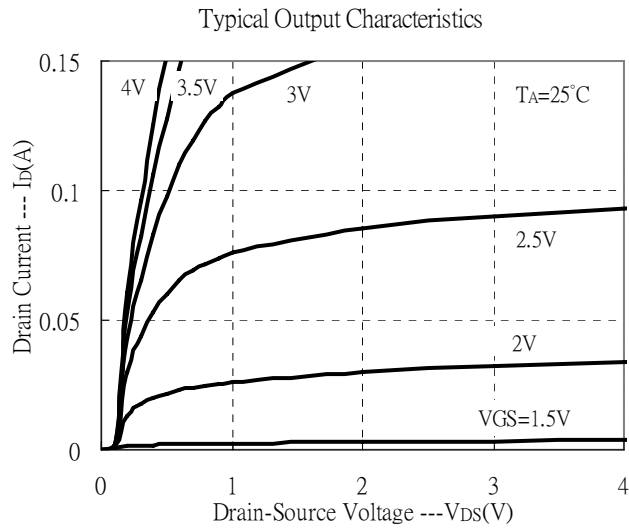
\*Pulse Test : Pulse Width ≤380μs, Duty Cycle ≤2%

**Ordering Information**

Device	Package	Shipping	Marking
MBNP2026G6	TSOP-6 (Pb-free lead plating & halogen-free package)	3000 pcs / Tape & Reel	2026



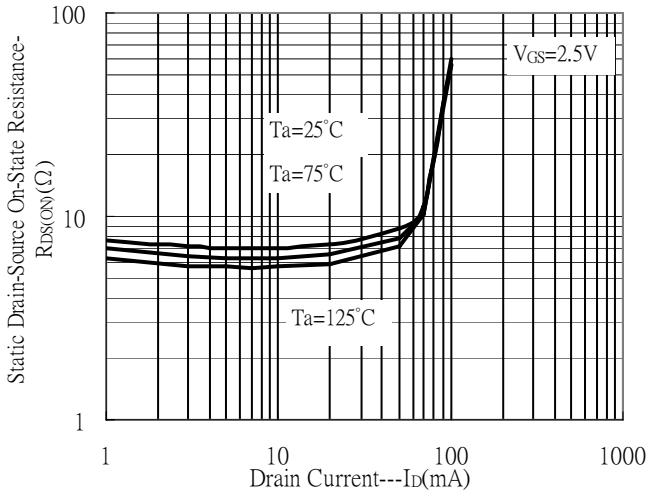
### N-channel MOSFET Characteristic Curves



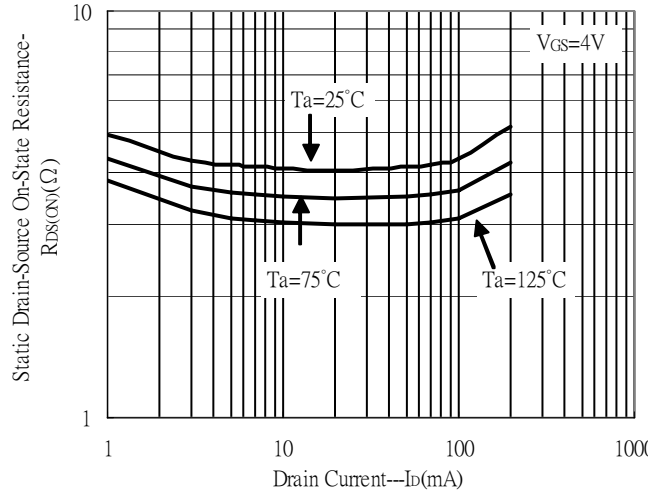


**N-channel MOSFET Characteristic Curves(Cont.)**

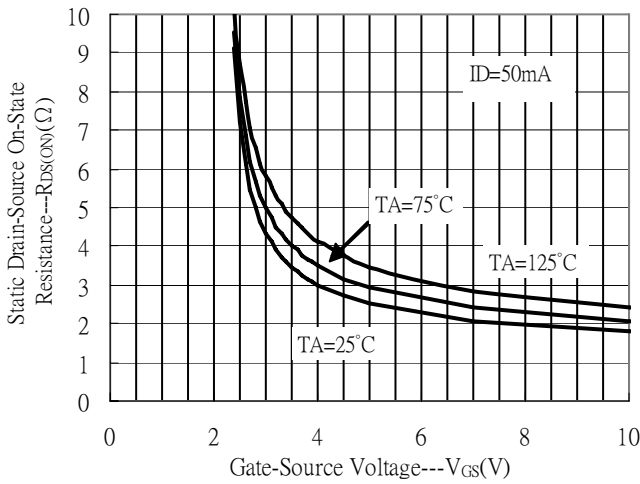
Static Drain-Source On-State Resistance vs Drain Current



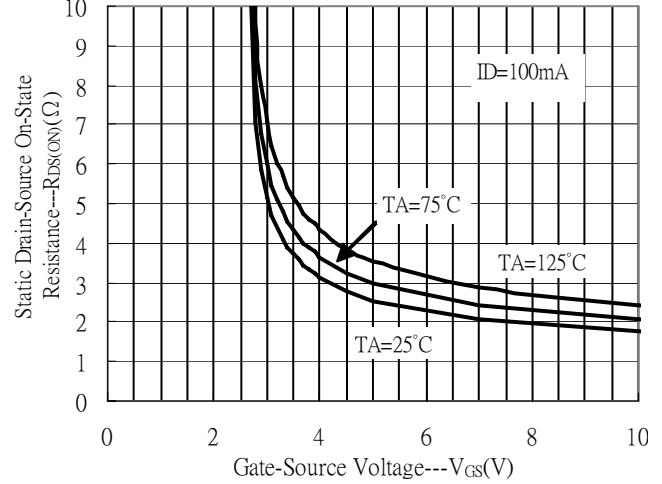
Static Drain-Source On-State Resistance vs Drain Current



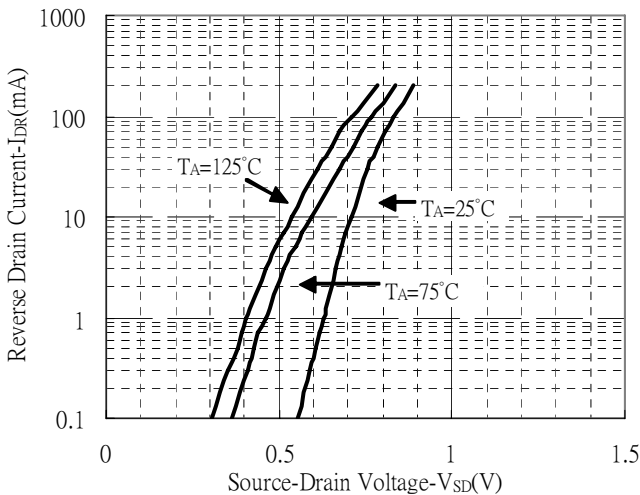
Static Drain-Source On-State Resistance vs Gate-Source Voltage



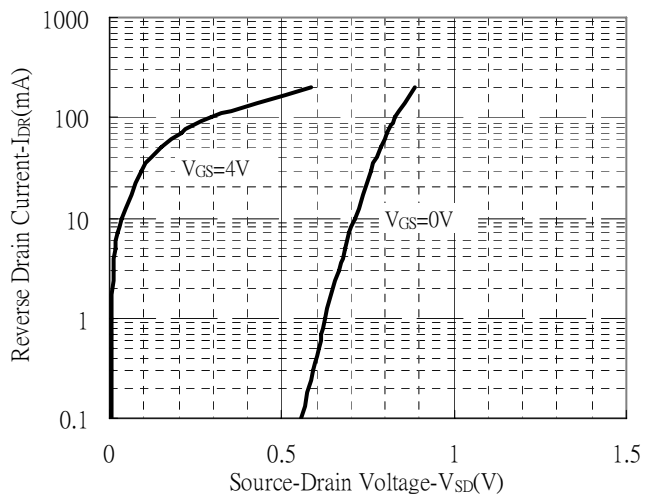
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Reverse Drain Current vs Source-Drain Voltage(I)

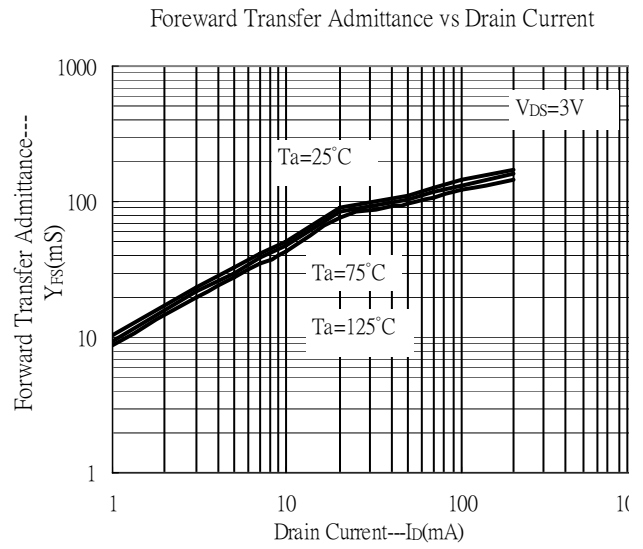
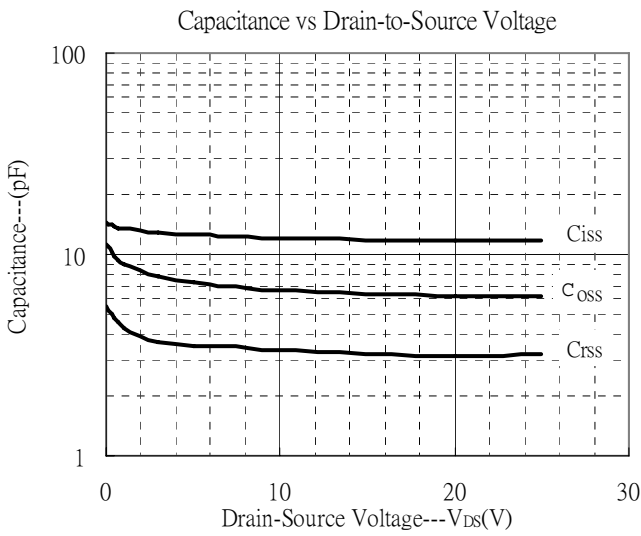


Reverse Drain Current vs Source-Drain Voltage(II)



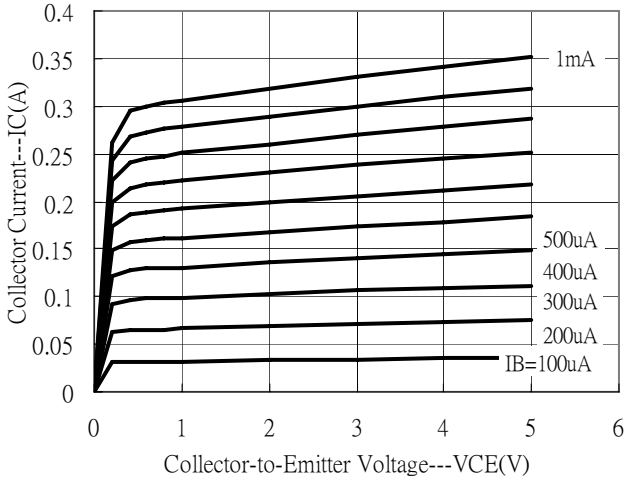


### N-channel MOSFET Characteristic Curves(Cont.)

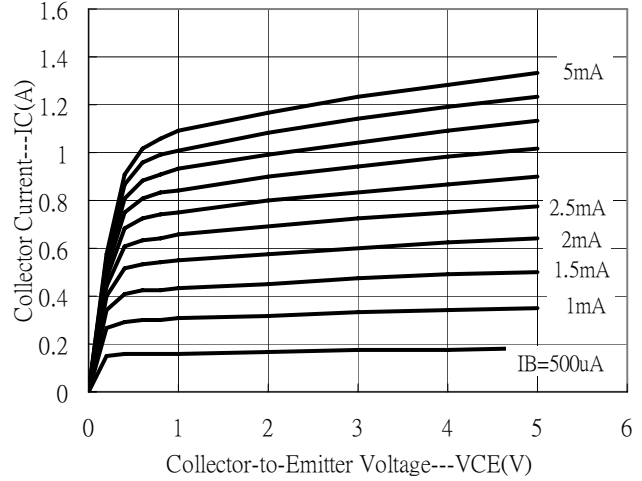


**PNP BJT Characteristic Curves**

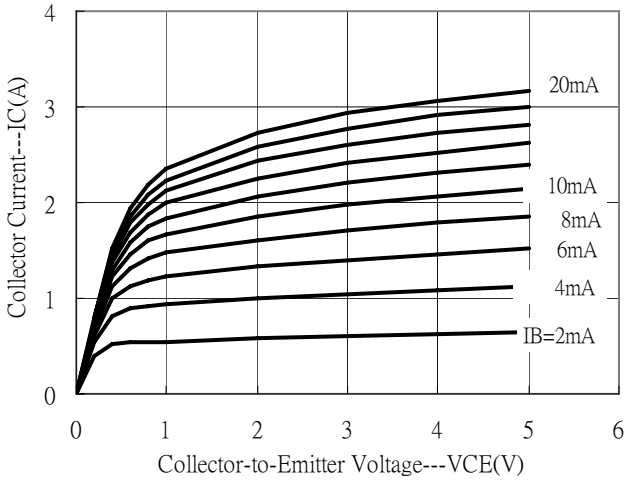
Emitter Grounded Output Characteristics



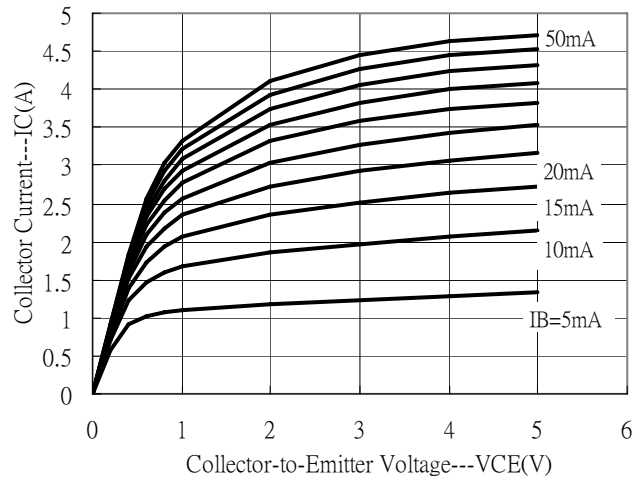
Emitter Grounded Output Characteristics



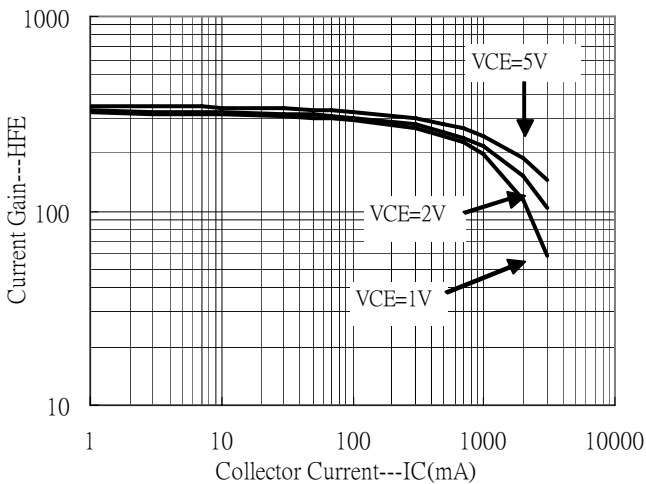
Emitter Grounded Output Characteristics



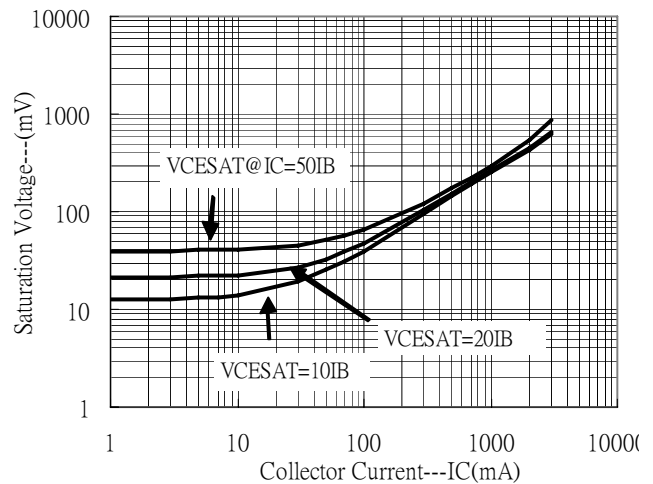
Emitter Grounded Output Characteristics



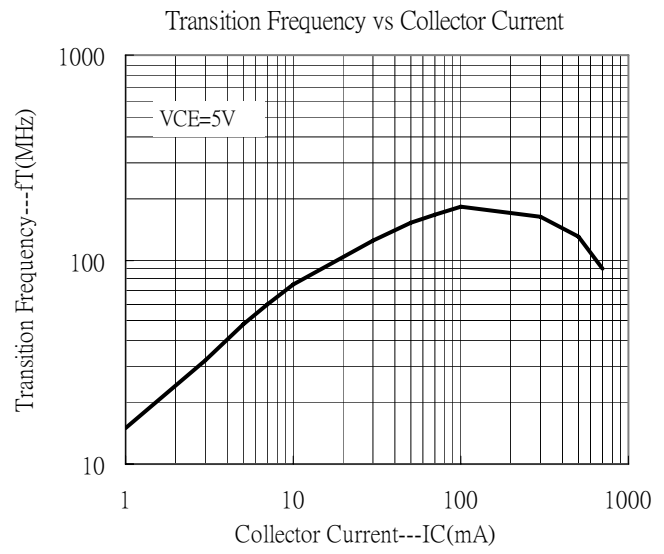
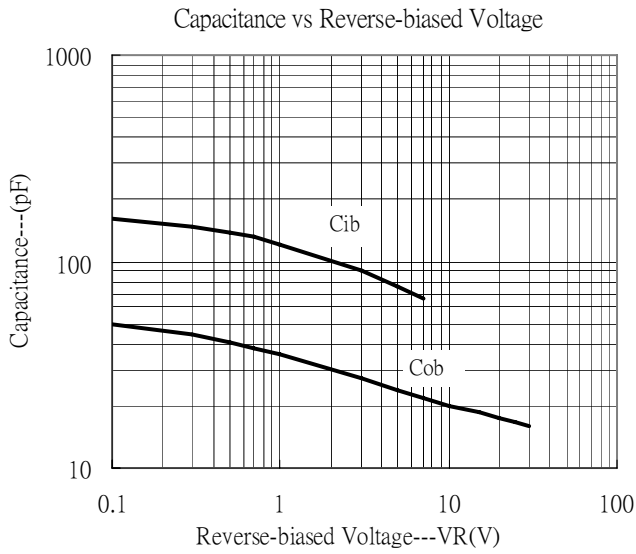
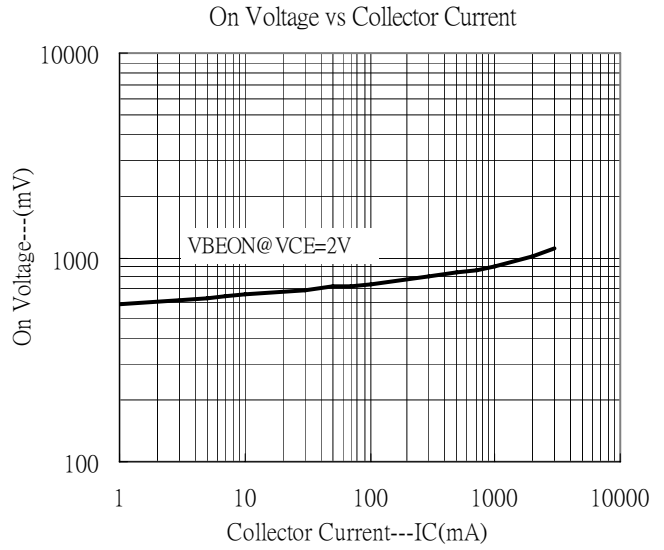
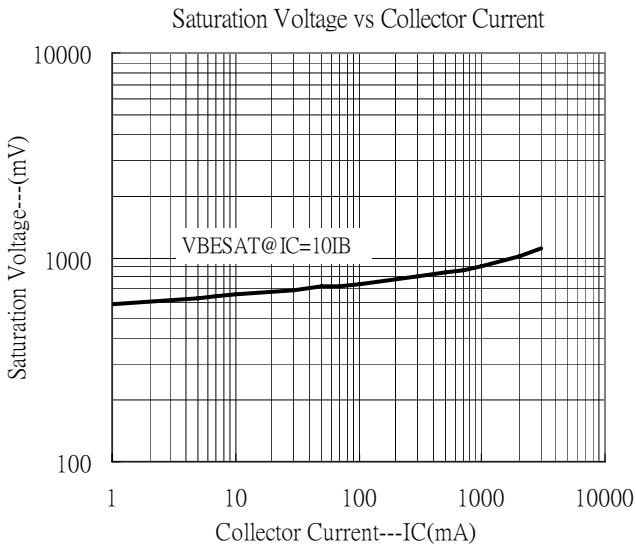
Current Gain vs Collector Current



Saturation Voltage vs Collector Current



**PNP BJT Characteristic Curves (Cont.)**

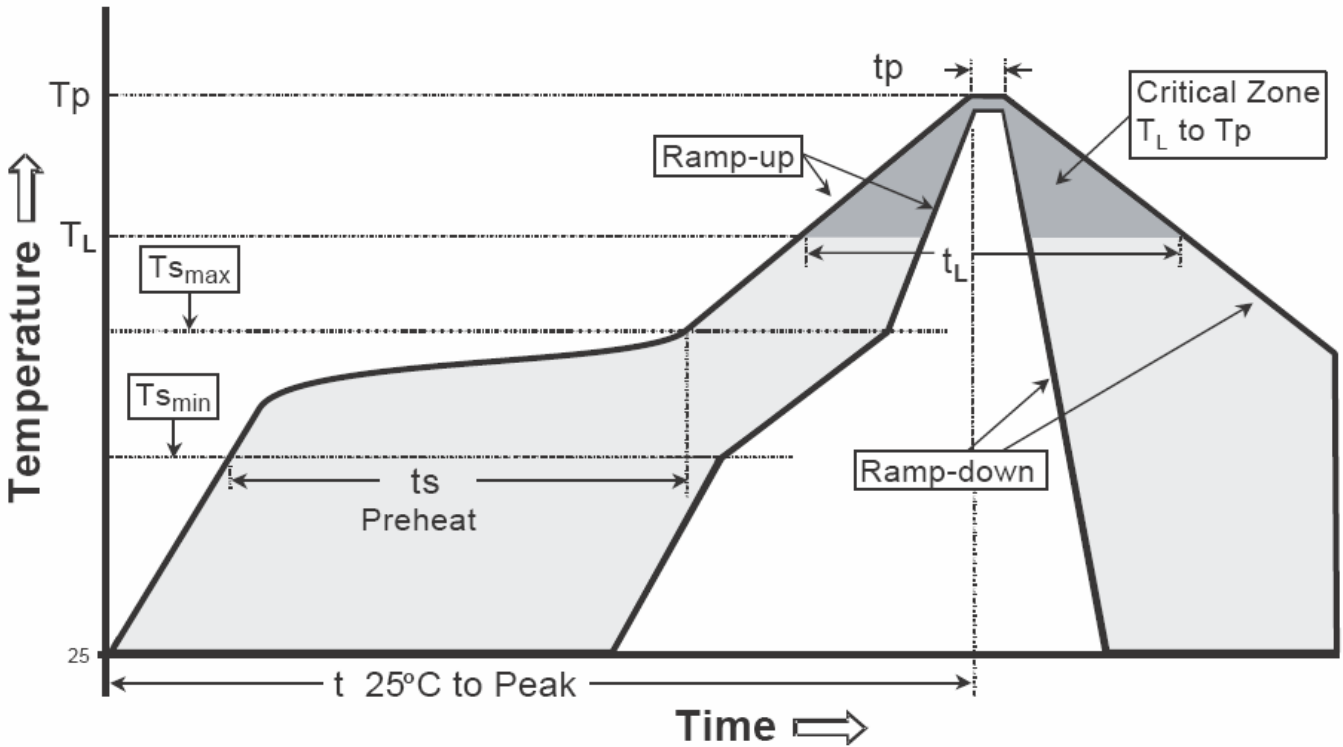




**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

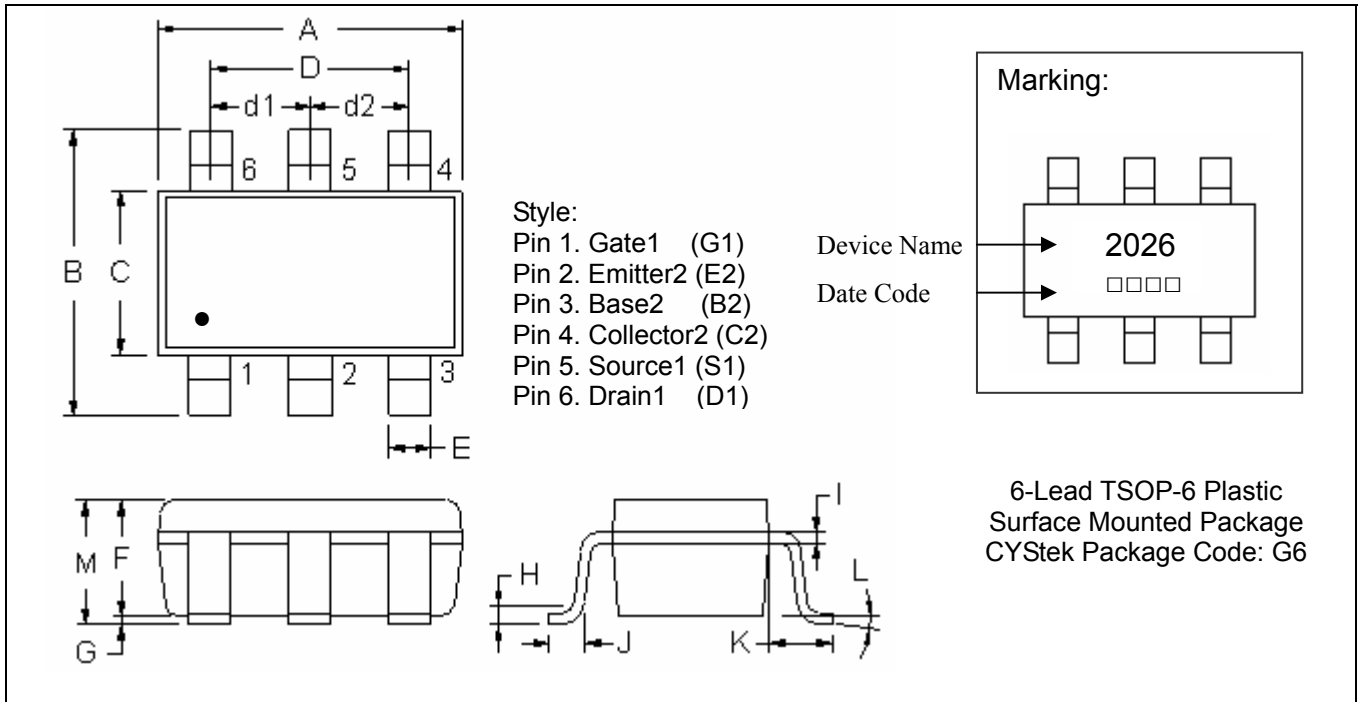
**Recommended temperature profile for IR reflow**



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (TL)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(TP)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

**TSOP-6 Dimension**



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1063	0.1220	2.70	3.10	G	0	0.0039	0	0.10
B	0.1024	0.1181	2.60	3.00	H	-	0.0098	-	0.25
C	0.0551	0.0709	1.40	1.80	I	0.0047 REF		0.12 REF	
D	0.0748 REF		1.90 REF		J	0.0177 REF		0.45 REF	
d1	0.0374 REF		0.95 REF		K	0.0236 REF		0.60 REF	
d2	0.0374 REF		0.95 REF		L	0°	10°	0°	10°
E	0.0118	0.0197	0.30	0.50	M	-	0.0433	-	1.10
F	0.0276	0.0394	0.70	1.00					

**Notes :** 1.Controlling dimension : millimeters.  
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material :**

- Lead : Pure tin plated.
- Mold Compound : Epoxy resin family, flammability solid burning class:UL94V-0.

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